

# DS90CP02 1.5 Gbps 2x2 LVDS Crosspoint Switch

Check for Samples: DS90CP02

#### **FEATURES**

- 1.5 Gbps per Channel
- Low Power: 70 mA in Dual Repeater Mode @1.5 Gbps
- **Low Output Jitter**
- Non-Blocking Architecture Allows 1:2 Splitter, 2:1 Mux, Crossover, and Dual Buffer Configurations
- Flow-Through Pinout
- LVDS/BLVDS/CML/LVPECL Inputs, LVDS **Outputs**
- Single 3.3V Supply
- **Separate Control of Inputs and Outputs Allows** for Power Savings
- Industrial -40 to +85°C Temperature Range
- 28-lead UQFN-28 Space Saving Package

# DESCRIPTION

The DS90CP02 is a 1.5 Gbps 2 x 2 LVDS crosspoint switch optimized for high-speed signal routing and switching over lossy FR-4 printed circuit board backplanes and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity. The non-blocking architecture allows connections of any input to any output or outputs.

Wide input common mode range allows the switch to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flow-through pinout allows easy board layout. The 3.3V supply, CMOS process, and LVDS I/O ensure high performance at low power over the entire industrial -40 to +85°C temperature range.

### **Block Diagram**

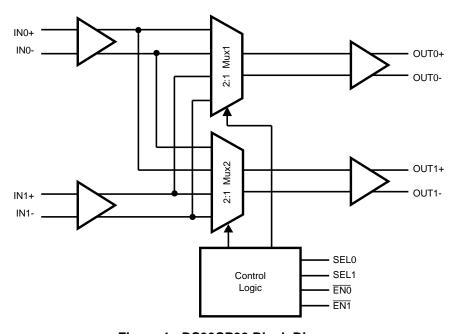


Figure 1. DS90CP02 Block Diagram

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#### **Table 1. PIN DESCRIPTIONS**

Pin Name	Pin Number	I/O, Type	Description				
DIFFERENT	IAL INPUTS	COMMON TO ALL	MUXES				
IN0+ IN0-	9 10	I, LVDS	Inverting and non-inverting differential inputs. LVDS, Bus LVDS, CML, or LVPECL compatible.				
IN1+ IN1-	12 13	I, LVDS	Inverting and non-inverting differential inputs. LVDS, Bus LVDS, CML, or LVPECL compatible.				
SWITCHED	DIFFERENTI	AL OUTPUTS					
OUT0+ OUT0-	27 26	O, LVDS	Inverting and non-inverting differential outputs. OUT0± can be connected to any one pair IN0±, or IN1±. LVDS compatible .				
OUT1+ 24 O, LVDS OUT1- 23			Inverting and non-inverting differential outputs. OUT1± can be connected to any one pair IN0±, or IN1±. LVDS compatible .				
DIGITAL CO	NTROL INTE	RFACE					
SEL0, SEL1	6 5	I, LVTTL	Select Control Inputs				
ENO, EN1	7 15	I, LVTTL	Output Enable Inputs				
N/C	8, 20, 28		Not Connected				
POWER							
V <sub>DD</sub>	11, 14, 16, 18, 19, 22, 25	I, Power	$V_{DD}$ = 3.3V ±0.3V. At least 4 low ESR 0.01 $\mu F$ bypass capacitors should be connected from $V_{DD}$ to GND plane.				
25 GND DAP, 1, 2, 3, 4, 17, 21		I, Power	Ground reference to LVDS and CMOS circuitry.  For the UQFN package, the DAP is used as the primary GND connection to the device.  The DAP is the exposed metal contact at the bottom of the UQFN-28 package. It should connected to the ground plane with at least 4 vias for optimal AC and thermal performance.				

# **Connection Diagram**

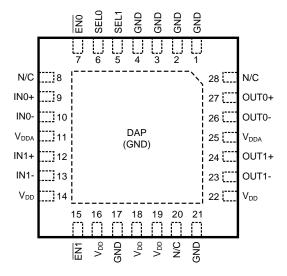


Figure 2. UQFN Top View
DAP = GND
See Package Number NJD0028A

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# **Configuration Select Truth Table**

SEL0	SEL1	EN0	EN1	OUT0	OUT1	Mode		
0	0	0	0	IN0	1:2 Splitter (IN1 powered down)			
0	1	0	0	IN0	Dual Channel Repeater			
1	0	0	0	IN1	IN0	Dual Channel Switch		
1	1	0	0	IN1	IN1	1:2 Splitter (IN0 powered down)		
0	1	0	1	IN0	INO PD Single Channel Repeater (Channel 1 powered do			
1	1	0	1	IN1	PD Single Channel Switch (IN0 and OUT1 powered dow			
0	0	1	0	PD	IN0 Single Channel Switch (IN1 and OUT0 powered down)			
0	1	1	0	PD	IN1 Single Channel Repeater (Channel 0 powered down)			
Х	Х	1	1	PD	PD Both Channels in Power Down Mode			
0	0	0	1			Invalid State*		
1	0	0	1			Invalid State*		
1	0	1	0			Invalid State*		
1	1	1	0			Invalid State*		

Product Folder Links: DS90CP02



#### **APPLICATION INFORMATION**

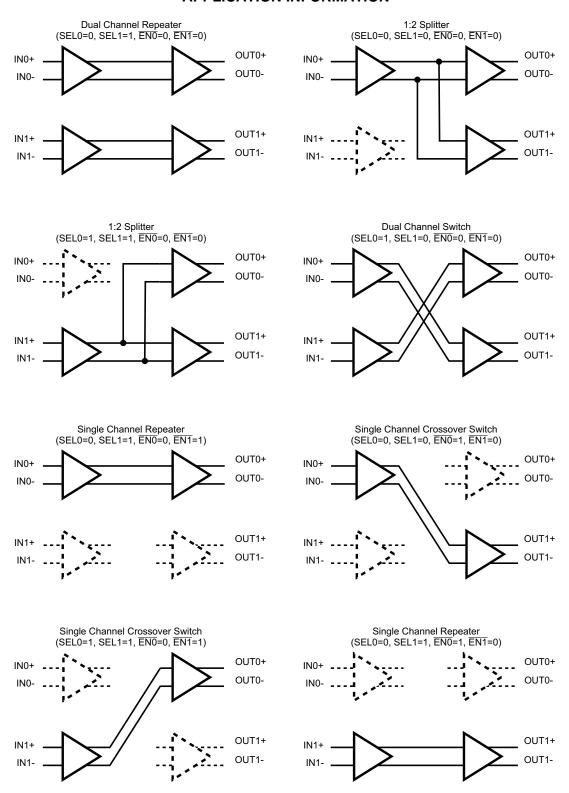


Figure 3. DS90CP02 Configuration Select Decode





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

**Absolute Maximum Ratings** (1)(2)

-0.3V to +4.0V
-0.3V to (V <sub>DD</sub> +0.3V)
-0.3V to +3.6V
-0.3V to +3.6V
40mA
+150°C
−65°C to +150°C
+260°C
4.31 W
34.5 mW/°C
29°C/W
6.5 kV
>250V

<sup>(1) &</sup>quot;Absolute Maximum Ratings" are the ratings beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits.

## **Recommended Operating Conditions**

	Min	Тур	Max	Unit
Supply Voltage (V <sub>DD</sub> – GND)	3.0	3.3	3.6	V
Receiver Input Voltage	0		3.6	V
Operating Free Air Temperature	-40	25	85	°C
Junction Temperature			150	°C

Product Folder Links: DS90CP02

<sup>(2)</sup> If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.



#### **Electrical Characteristics**

Over recommended operating supply and temperature ranges unless other specified

Symbol	Parameter	Conditions	Min	Typ (1)	Max	Units
LVTTL D	C SPECIFICATIONS (SEL0, SEL1, EN	1, EN2)				
V <sub>IH</sub>	High Level Input Voltage		2.0		$V_{DD}$	V
V <sub>IL</sub>	Low Level Input Voltage		GND		0.8	V
I <sub>IH</sub>	High Level Input Current	$V_{IN} = V_{DD} = V_{DDMAX}$	-10		+10	μA
I <sub>IL</sub>	Low Level Input Current	$V_{IN} = V_{SS}, V_{DD} = V_{DDMAX}$	-10		+10	μΑ
C <sub>IN1</sub>	Input Capacitance	Any Digital Input Pin to V <sub>SS</sub>		3.5		pF
V <sub>CL</sub>	Input Clamp Voltage	I <sub>CL</sub> = −18 mA	<b>-</b> 1.5	-0.8		V
LVDS INF	PUT DC SPECIFICATIONS (IN0±, IN1±	)				
V <sub>TH</sub>	Differential Input High Threshold (2)	V <sub>CM</sub> = 0.8V or 1.2V or 3.55V, V <sub>DD</sub> = 3.6V		0	100	mV
V <sub>TL</sub>	Differential Input Low Threshold	V <sub>CM</sub> = 0.8V or 1.2V or 3.55V, V <sub>DD</sub> = 3.6V	-100	0		mV
V <sub>ID</sub>	Differential Input Voltage	$V_{CM} = 0.8V$ to 3.55V, $V_{DD} = 3.6V$	100			mV
V <sub>CMR</sub>	Common Mode Voltage Range	V <sub>ID</sub> = 150 mV, V <sub>DD</sub> = 3.6V	0.05		3.55	V
C <sub>IN2</sub>	Input Capacitance	IN+ or IN- to V <sub>SS</sub>		3.5		pF
I <sub>IN</sub>	Input Current	$V_{IN} = 3.6V$ , $V_{DD} = V_{DDMAX}$ or $0V$	-10		+10	μA
		$V_{IN} = 0V$ , $V_{DD} = V_{DDMAX}$ or $0V$	-10		+10	μA
LVDS OU	ITPUT DC SPECIFICATIONS (OUT0±,	OUT1±)		•		
V <sub>OD</sub>	Differential Output Voltage, 0% Pre-emphasis (2)	$R_L = 100\Omega$ between OUT+ and OUT-	250	400	575	mV
$\Delta V_{OD}$	Change in V <sub>OD</sub> between Complementary States		-35		35	mV
Vos	Offset Voltage (3)		1.09	1.25	1.475	V
ΔV <sub>OS</sub>	Change in V <sub>OS</sub> between Complementary States		-35		35	mV
I <sub>OS</sub>	Output Short Circuit Current, One Complementary Output	OUT+ or OUT- Short to GND		-60	-90	mA
C <sub>OUT</sub>	Output Capacitance	OUT+ or OUT- to GND when TRI- STATE		5.5		pF
SUPPLY	CURRENT (Static)					
I <sub>CC0</sub>	Supply Current	All inputs and outputs enabled and active, terminated with differential load of 100Ω between OUT+ and OUT		42	60	mA
I <sub>CC1</sub>	Supply Current - one channel powered down	Single channel crossover switch or single channel repeater modes (1 channel active, one channel in power down mode)		22	30	mA
I <sub>CC2</sub>	Supply Current - one input powered down	Splitter mode (One input powered down, both outputs active)		30	40	mA
I <sub>CCZ</sub>	TRI-STATE Supply Current	Both input/output Channels in Power Down Mode		1.4	2.5	mA
SWITCHI	NG CHARACTERISTICS—LVDS OUT	PUTS (Figure 4, Figure 5)				
t <sub>LHT</sub>	Differential Low to High Transition Time	Use an alternating 1 and 0 pattern at 200 Mb/s, measure between 20% and 80% of	70	150	215	ps
t <sub>HLT</sub>	Differential High to Low Transition Time	V <sub>OD</sub> .	50	135	180	ps
t <sub>PLHD</sub>	Differential Low to High Propagation Delay	Use an alternating 1 and 0 pattern at 200 Mb/s, measure at 50% V <sub>OD</sub> between	0.5	2.4	3.5	ns
t <sub>PHLD</sub>	Differential High to Low Propagation Delay	input to output.	0.5	2.4	3.5	ns
t <sub>SKD1</sub>	Pulse Skew	telho=tehlo		55	120	ps

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<sup>(2)</sup> 

Typical parameters are measured at  $V_{DD}$  = 3.3V,  $T_A$  = 25°C. They are for reference purposes, and are not production-tested. Differential output voltage  $V_{OD}$  is defined as ABS(OUT+-OUT-). Differential input voltage  $V_{ID}$  is defined as ABS(IN+-IN-). Output offset voltage  $V_{OS}$  is defined as the average of the LVDS single-ended output voltages at logic high and logic low states. (3)



### **Electrical Characteristics (continued)**

Over recommended operating supply and temperature ranges unless other specified.

Symbol	Parameter	Conditions	Min	<b>Typ</b> (1)	Max	Units
t <sub>SKCC</sub>	Output Channel to Channel Skew	Difference in propagation delay (t <sub>PLHD</sub> or t <sub>PHLD</sub> ) among all output channels in Splitter mode (any one input to all outputs).	0	130	315	ps
t <sub>JIT</sub>	Jitter	RJ - Clock Pattern 750 MHz <sup>(5)</sup>		1.4	2.5	psrms
		DJ - K28.5 Pattern 1.5 Gbps <sup>(6)</sup>		42	75	psp-p
		TJ - PRBS 2 <sup>23</sup> -1 Pattern 1.5 Gbps <sup>(7)</sup>		93	126	psp-p
t <sub>ON</sub>	LVDS Output Enable Time	Time from ENx to OUT± change from TRI-STATE to active.	50	110	150	ns
t <sub>OFF</sub>	LVDS Output Disable Time	Time from ENx to OUT± change from active to TRI-STATE.		5	12	ns
t <sub>SW</sub>	LVDS Switching Time SELx to OUT±	Time from configuration select (SELx) to new switch configuration effective for OUT±.		110	150	ns

<sup>(4)</sup> Jitter is not production tested, but guaranteed through characterization on a sample basis.

Product Folder Links: DS90CP02

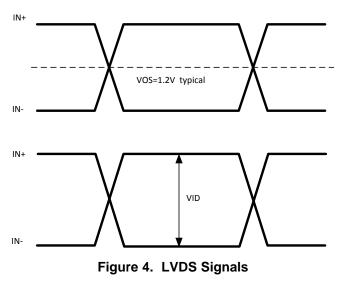
<sup>(5)</sup> Random Jitter, or RJ, is measured RMS with a histogram including 1500 histogram window hits. The input voltage = V<sub>ID</sub> = 500mV, 50% duty cycle at 750MHz, t<sub>r</sub> = t<sub>f</sub> = 50ps (20% to 80%).

<sup>(6)</sup> Deterministic Jitter, or DJ, is measured to a histogram mean with a sample size of 350 hits. The input voltage =  $V_{ID} = 500$ mV, K28.5 pattern at 1.5 Gbps,  $t_r = t_f = 50$ ps (20% to 80%). The K28.5 pattern is repeating bit streams of (0011111010 1100000101).

<sup>(7)</sup> Total Jitter, or TJ, is measured peak to peak with a histogram including 3500 window hits. Stimulus and fixture jitter has been subtracted. The input voltage =  $V_{ID}$  = 500mV,  $2^{23}$ -1 PRBS pattern at 1.5 Gbps,  $t_r = t_f$  = 50ps (20% to 80%).



## **Timing Diagrams**



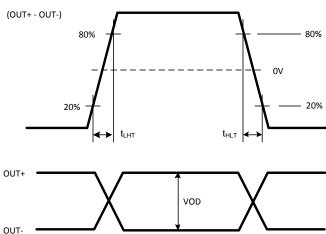


Figure 5. LVDS Output Transition Time

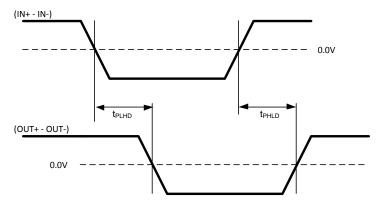


Figure 6. LVDS Output Propagation Delay



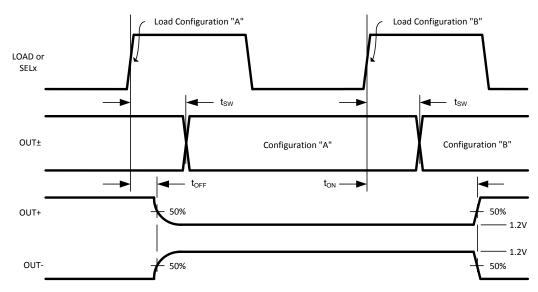
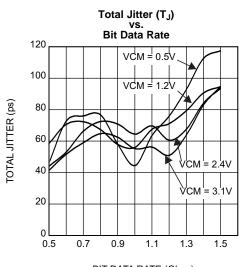


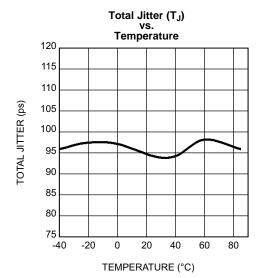
Figure 7. Configuration and Output Enable/Disable Timing

### **Typical Performance**



BIT DATA RATE (Gbps)

Total Jitter measured at 0V differential while running a PRBS  $2^{23}$ -1 pattern in single channel repeater mode.  $V_{CC}=3.3V,\, T_A=+25^{\circ}C,\, V_{ID}=0.5V$  Figure 8.



Total Jitter measured at 0V differential while running a PRBS  $2^{23}$ -1 pattern in dual channel repeater mode.  $V_{CC} = 3.3V, V_{ID} = 0.5V, V_{CM} = 1.2V, 1.5$  Gbps data rate Figure 9.

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#### SNLS267A - NOVEMBER 2008-REVISED MARCH 2013



## **REVISION HISTORY**

Ch	nanges from Original (March 2013) to Revision A	Page
•	Changed layout of National Data Sheet to TI format	9

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## PACKAGE OPTION ADDENDUM

10-Dec-2020

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
DS90CP02SP/NOPB	ACTIVE	UQFN	NJD	28	1000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 85	CP02SP	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

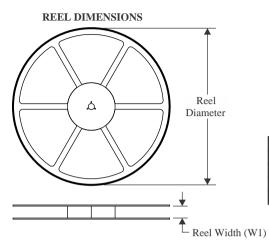
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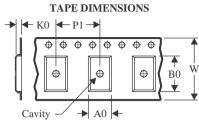
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# **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

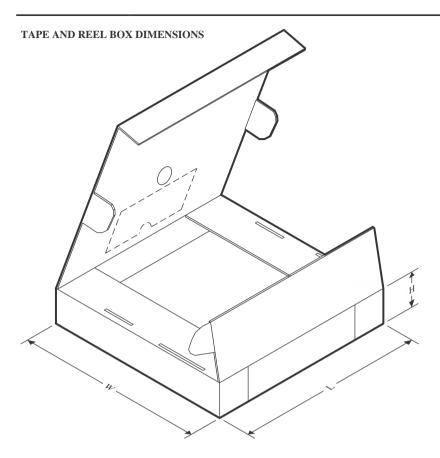


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90CP02SP/NOPB	UQFN	NJD	28	1000	178.0	12.4	5.3	5.3	1.3	8.0	12.0	Q1

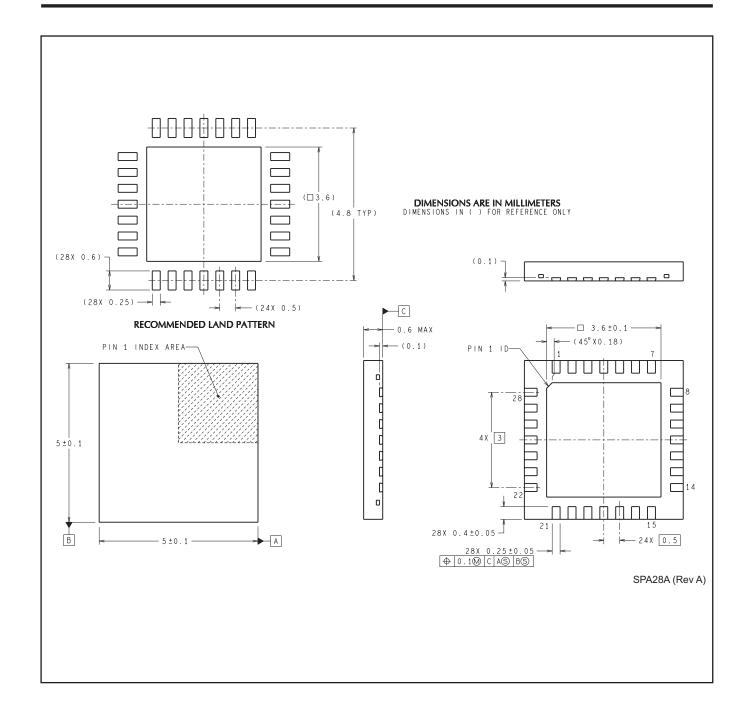
# **PACKAGE MATERIALS INFORMATION**

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#### \*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
I	DS90CP02SP/NOPB	UQFN	NJD	28	1000	208.0	191.0	35.0





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